

Search Notes

Application/Control No.

09/775,464

Examiner

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Applicant(s)/Patent under
Reexamination

AN, CHEOL-HONG

Art Unit

263XB

SEARCHED

Class	Subclass	Date	Examiner
375	225	6/21/2005	JP
	224	6/21/2005	JP
	316	6/21/2005	JP
	354	6/21/2005	JP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	225	6/21/2005	JP
	224	6/21/2005	JP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East EPO/JPO USPAT/USPGPUB	6/21/2005	JP
Inventor Name Search	6/21/2005	JP